

N-channel 100 V 71 m Ω standard level MOSFET in LFPAK33 designed specifically for PoE applications

26 March 2013

Product data sheet

1. General description

New standards and proprietary approaches are enabling the next generation of Powerover-Ethernet (PoE) systems capable of delivering up to 100W to each powered device (PD). Large screen LCD displays, 3G / 4G / Wi-Fi hot-spots and pan-tilt-zoom CCTV cameras, for example, are placing increased demands on the power sourcing equipment (PSE) in terms of "soft-start" procedures, resilience to short-circuits, thermal management and power density. Part of NXP's "NextPower Live" MOSFET portfolio, the PSMN075-100MSE has been designed specifically to compliment the latest PoE controllers, offering both superior linear mode operation and very low R_{DS(on)} in a costeffective, industry compatible, LFPAK33 package.

2. Features and benefits

- Enhanced forward biased safe operating area for superior linear mode operation
- Low Rdson for low conduction losses
- Ultra reliable LFPAK33 package no glue, no wires, 175°C
- Very low I_{DSS}

3. Applications

- IEEE802.3at and proprietary solutions (type 2)
- Suitable for PoE applications upto 30W
- Use PSMN040-100MSE for higher power requirements

4. Quick reference data

Table 1. Qui	ck reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	100	V
I _D	drain current	T _j = 25 °C; V _{GS} = 10 V; <u>Fig. 1</u>	-	-	18	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	-	65	W
Static charact	eristics					
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 5 A; T _j = 25 °C; <u>Fig. 12</u>	-	57	71	mΩ
Dynamic char	acteristics					
Q _{GD}	gate-drain charge	V _{GS} = 10 V; I _D = 5 A; V _{DS} = 50 V; T _j 25 °C; <u>Fig. 14; Fig. 15</u>	-	5.3	-	nC





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Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
Q _{G(tot)}	total gate charge	$V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; V_{DS} = 50 \text{ V};$ T _j = 25 °C; Fig. 14; Fig. 15		-	16.4	-	nC
Avalanche Ruggedness							
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	V_{GS} = 10 V; T _{j(init)} = 25 °C; I _D = 18 A; V _{sup} ≤ 100 V; R _{GS} = 50 Ω; unclamped; Fig. 3		-	-	25	mJ

5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline Graphic symbol	
1	S	source		
2	S	source		
3	S	source		
4	G	gate	mbb076 S	
mb	D	mounting base; connected to drain	LFPAK33 (SOT1210)	

6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
PSMN075-100MSE	LFPAK33	Plastic single ended surface mounted package (LFPAK33); 4 leads	SOT1210			

7. Marking

Table 4. Marking codes	
Type number	Marking code
PSMN075-100MSE	M75E10

8. Limiting values

Table 5. Limiting values

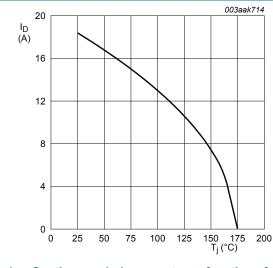
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	100	V
V _{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	100	V
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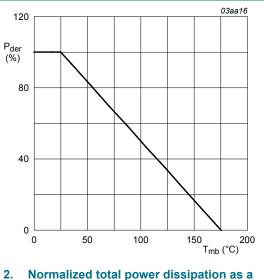
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Symbol	Parameter	Conditions	Min	Max	Unit
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 1</u>	-	18	А
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 1</u>	-	13	А
I _{DM}	peak drain current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$; Fig. 4	-	74	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>	-	65	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-dra	in diode		I		
I _S	source current	T _{mb} = 25 °C	-	54	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^\circ C$	-	74	А
Avalanche	Ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; T _{j(init)} = 25 °C; I _D = 18 A; V_{sup} ≤ 100 V; R _{GS} = 50 Ω; unclamped; Fig. 3	-	25	mJ





 $V_{GS} \ge 10V$

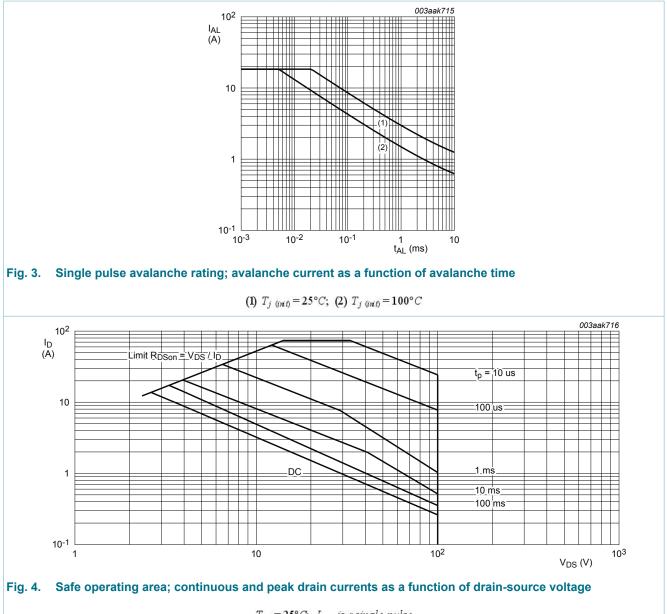




 $P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$

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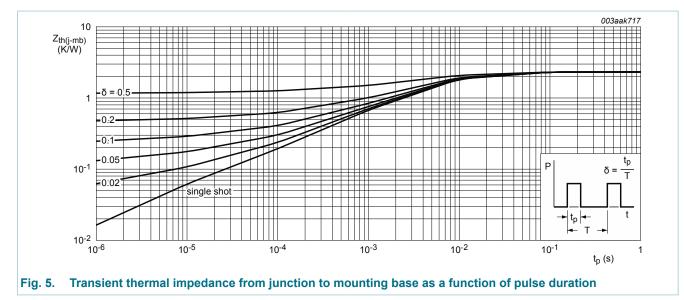


 $T_{mb} = 25^{\circ}C; \ I_{DM}$ is a single pulse

9. Thermal characteristics

Table 6. The	rmal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	2.09	2.32	K/W

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10. Characteristics

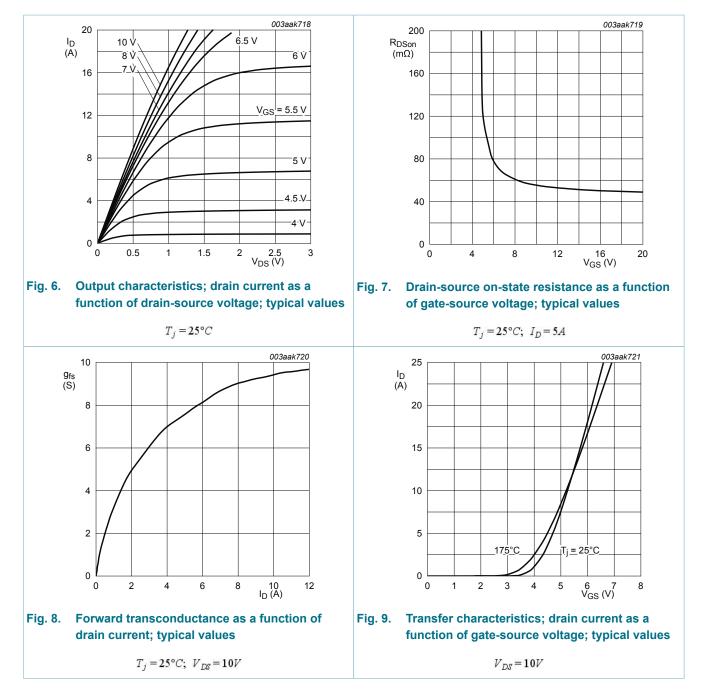
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics	1 I				
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	100	-	-	V
	breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	90	-	-	V
V _{GS(th)}	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; Fig. 10; Fig. 11	2.3	3.3	4	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; Fig. 10	1	-	-	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = -55 °C; Fig. 10	-	-	4.6	V
I _{DSS} drain leakage current	drain leakage current	V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 °C	-	0.01	1	μA
		V _{DS} = 100 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
		V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state	V _{GS} = 10 V; I _D = 5 A; T _j = 25 °C; <u>Fig. 12</u>	-	57	71	mΩ
	resistance	V _{GS} = 10 V; I _D = 5 A; T _j = 100 °C; Fig. 13; Fig. 12	-	-	128	mΩ
		V _{GS} = 10 V; I _D = 5 A; T _j = 175 °C; Fig. 13; Fig. 12	-	-	192	mΩ
R _G	gate resistance	f = 10 MHz	_	1.55	-	Ω

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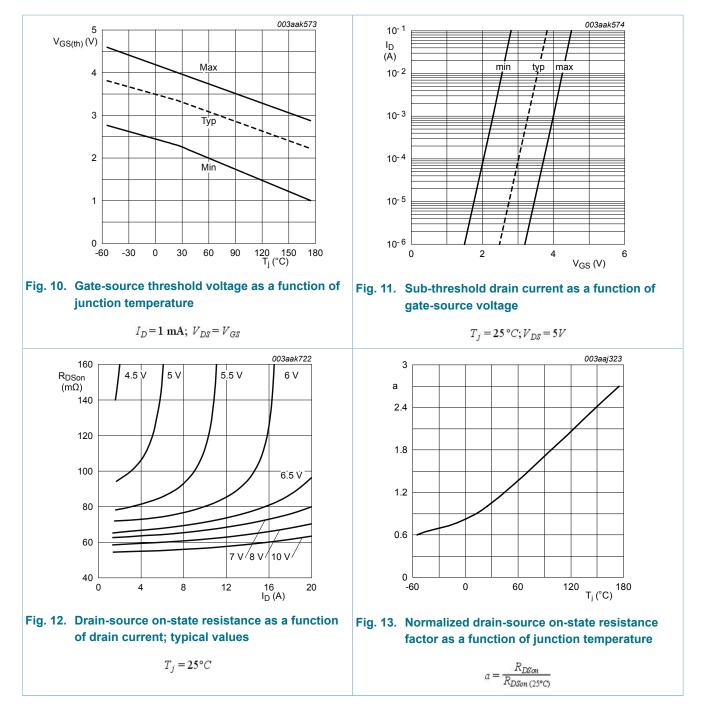
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic ch	naracteristics					
Q _{G(tot)}	total gate charge	I _D = 5 A; V _{DS} = 50 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 14; Fig. 15</u>	-	16.4	-	nC
		$I_{D} = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V};$ $T_{j} = 25 \text{ °C}$	-	12.9	-	nC
Q _{GS}	gate-source charge	$I_D = 5 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ °C}; \text{ Fig. 14}; \text{ Fig. 15}$	-	3.1	-	nC
Q _{GS(th)}	pre-threshold gate- source charge		-	2.1	-	nC
Q _{GS(th-pl)}	post-threshold gate- source charge		-	1	-	nC
Q _{GD}	gate-drain charge	I _D = 5 A; V _{DS} = 50 V; V _{GS} = 10 V; T _j 25 °C; <u>Fig. 14; Fig. 15</u>	-	5.3	-	nC
V _{GS(pl)}	gate-source plateau voltage	I _D = 5 A; V _{DS} = 50 V; T _j = 25 °C; Fig. 14; Fig. 15	-	4.3	-	V
C _{iss}	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; \text{ f} = 1 \text{ MHz};$ T _j = 25 °C; Fig. 16	-	773	-	pF
C _{oss}	output capacitance		-	66	-	pF
C _{rss}	reverse transfer capacitance		-	48	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 50 V; R _L = 10 Ω; V _{GS} = 10 V;	-	5.5	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 °C$	-	5.8	-	ns
t _{d(off)}	turn-off delay time		-	12.4	-	ns
t _f	fall time	1	-	6.2	-	ns
Source-dra	in diode		I			
V _{SD}	source-drain voltage	I_{S} = 15 A; V_{GS} = 0 V; T_{j} = 25 °C; <u>Fig. 17</u>	-	0.89	1.2	V
t _{rr}	reverse recovery time	$I_{\rm S}$ = 5 A; dI _S /dt = -100 A/µs; V _{GS} = 0 V;	-	35.8	-	ns
Q _r	recovered charge	V _{DS} = 50 V; T _j = 25 °C	-	50.7	-	nC

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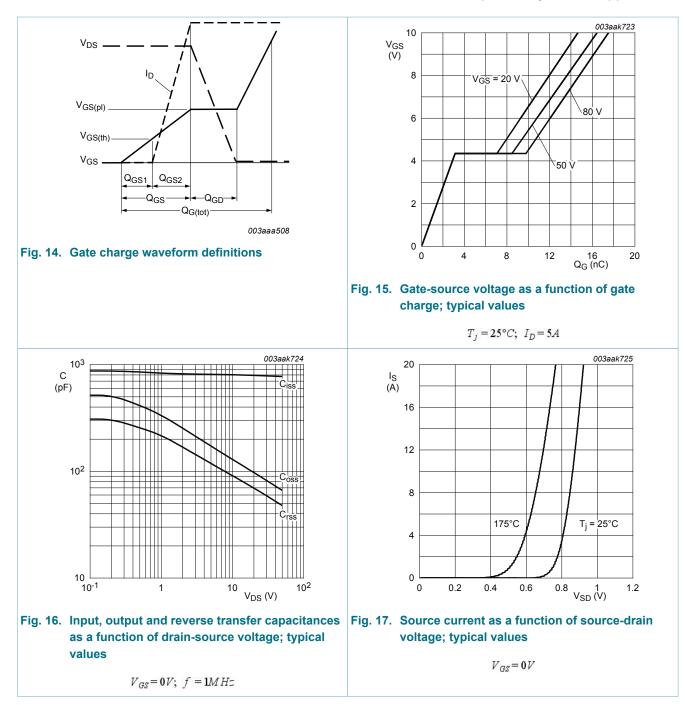
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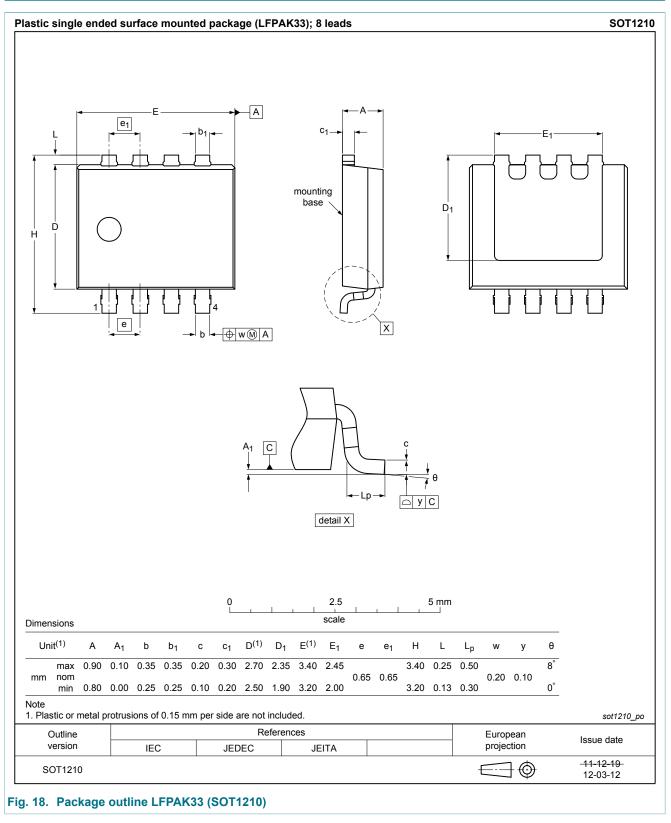
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11. Package outline



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12. Legal information

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Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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